



**Hisense Electric Co., Ltd.**

Application  
For  
Certification  
**FCC ID: W9HLCDD0044**

**LED LCD TV**

**Model: LTDN40D50US**  
**Additional Model: 40D50, 40H3B\***

Computer Peripheral

Report No.: 150213027SZN-001

Prepared and Checked by:

Approved by:

Sign on file

Jenner Liu  
Assistant Engineer

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Andy Yan  
Senior Project Engineer  
Date: March 10, 2015

- The test results reported in this test report shall refer only to the sample actually tested and shall not refer or be deemed to refer to bulk from which such a sample may be said to have been obtained.
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- For Terms And Conditions of the services, it can be provided upon request.
- The evaluation data of the report will be kept for 3 years from the date of issuance.

TRF No.: FCC 15C\_PC\_b

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## INTERTEK TESTING SERVICES

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### LIST OF EXHIBITS

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## INTERTEK TESTING SERVICES

### MEASUREMENT / TECHNICAL REPORT

**Hisense Electric Co., Ltd.**  
**MODEL: LTDN40D50US**  
**Additional Model: 40D50, 40H3B\***

**FCC ID: W9HLCDD0044**

This report concerns (check one:) Original Grant ☒ Class II Change ☐

Equipment Type: JBP-Class B Computing Device Peripheral

Deferred grant requested per 47 CFR 0.457(d)(1)(ii)? Yes ☐ No ☒

If yes, defer until: \_\_\_\_\_  
date

Company Name agrees to notify the Commission by: \_\_\_\_\_  
date

of the intended date of announcement of the product so that the grant can be issued on that date.

Transition Rules Request per 15.37? Yes ☐ No ☒

If no, assumed Part 15, Subpart B for unintentional radiator – the new 47 CFR [10-01-13 Edition] provision.

Report prepared by:

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# INTERTEK TESTING SERVICES

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## INTERTEK TESTING SERVICES

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### List of attached file

Exhibit Type	File Description	Filename
Test Report	Test Report	report.pdf
Test Setup Photo	Radiated photos	radiated photos.pdf
Test Setup Photo	Conducted photos	conducted photos.pdf
External Photo	External Photos	external photos.pdf
Internal Photo	Internal Photos	internal photos.pdf
Block Diagram	Block Diagram	block.pdf
ID Label / Location	Label Artwork and Location	label.pdf
User Manual	User Manual	manual.pdf
Cover Letter	Confidential Letter	request.pdf
Cover Letter	Letter of Agency	agency.pdf

# **INTERTEK TESTING SERVICES**

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## **EXHIBIT 1**

### **GENERAL DESCRIPTION**

## INTERTEK TESTING SERVICES

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### 1.0 **General Description**

#### 1.1 Product Description

The Equipment Under Test (EUT) is a LED LCD TV. The device can be used to connect PC by HDMI and VGA port. The EUT is powered by 120V/60Hz.

The Models: 40D50, 40H3B\* are the same as the Model: LTDN40D50US in hardware aspect. The difference in model number serves as marketing strategy.

#### 1.2 Related Submittal(s) Grants

This is an application for certification of a computer peripheral. Other digital functions were reported in the verification report: 150213026SZN-001.

## INTERTEK TESTING SERVICES

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### 1.3 Test Methodology

Both AC mains line-conducted and radiated emission measurements were performed according to the procedures in ANSI C63.4 (2009). Radiated emission measurement was performed in Semi-anechoic chamber and conducted emission measurement was performed in shield room. For radiated emission measurement, preliminary scans were performed in the semi-anechoic chamber only to determine the worst case modes. All radiated tests were performed at an antenna to EUT distance of 3 meters, unless stated otherwise in the "**Justification Section**" of this Application.

### 1.4 Test Facility

The Semi-anechoic chamber and shielding room used to collect the radiated data and conducted data are **Intertek Testing Services Shenzhen Ltd. Kejiyuan Branch** and located at 6F, D Block, Huahan Building, Langshan Road, Nanshan District, Shenzhen, P. R. China. This test facility and site measurement data have been fully placed on file with the FCC (Registration Number: 242492).



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## **INTERTEK TESTING SERVICES**

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### **EXHIBIT 2**

### **SYSTEM TEST CONFIGURATION**

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## INTERTEK TESTING SERVICES

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### 2.0 **System Test Configuration**

#### 2.1 Justification

The system was configured for testing in a typical fashion (as a customer would normally use it), and in the confines as outlined in ANSI C63.4 (2009).

The device was powered by AC 120V/60Hz during the test. The worst case data was reported in this report.

For maximizing emissions, the EUT was rotated through 360°, the antenna height was varied from 1 meter to 4 meters above the ground plane, and the antenna polarization was changed. The step by step procedure for maximizing emissions led to the data reported in Exhibit 3.0.

The rear of unit shall be flushed with the rear of the table.

The equipment under test (EUT) was configured for testing in a typical fashion (as a customer would normally use it). The EUT was placed on turntable, which enabled the engineer to maximize emissions through its placement in the three orthogonal axes.

The frequency range from 30MHz to 2GHz was searched for spurious emissions from the device. Only those emissions reported were detected. All other emissions were at least 20 dB below the applicable limits.

#### 2.2 EUT Exercising Software

N/A

#### 2.3 Special Accessories

N/A

#### 2.4 Equipment Modification

Any modifications installed previous to testing by Hisense Electric Co., Ltd. will be incorporated in each production model sold / leased in the United States.

No modifications were installed by Intertek Testing Services Shenzhen Ltd. Kejiyuan Branch.

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## INTERTEK TESTING SERVICES

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### 2.5 Measurement Uncertainty

When determining the test conclusion, the Measurement Uncertainty of test has been considered.

### 2.6 Support Equipment List and Description

This product was tested in the following configuration:

Refer List:

Description	Manufacturer	Model No.
Laptop	Lenovo	X1
Laptop	Lenovo	T420
Hard Disk	Smart.drive	HD-003
USB Memory	TOSHIBA	UHYBS-004G-BL
1394 Cable	Smart.drive	Unshielded, Length 180cm
USB Cable	Smart.drive	Unshielded, Length 155cm
Dummy Load	N/A	N/A
VGA Cable	HP	Unshielded, Length 150cm
PC Audio Cable	N/A	Unshielded, Length 180cm
HDMI Cable*3	N/A	UnShielded, Length 180cm
AV Cable	N/A	Unshielded, Length 120cm
YPbPr Cable	N/A	Unshielded, Length 120cm
Digital Audio Out Cable	N/A	Unshielded, Length 120cm
Tuner Resister	N/A	75ohm
Headphone	N/A	Unshielded, Length 110cm
Remote controller	Hisense	N/A

## **INTERTEK TESTING SERVICES**

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### **EXHIBIT 3**

### **EMISSION RESULTS**

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### 3.0 **Emission Results**

Data is included worst case configuration (the configuration which resulted in the highest emission levels). A sample calculation, configuration photographs and data tables of the emissions are included.

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## INTERTEK TESTING SERVICES

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### 3.1 Field Strength Calculation

The field strength is calculated by adding the reading on the Spectrum Analyzer to the factors associated with preamplifiers (if any), antennas, cables, pulse desensitization and average factors (when specified limit is in average and measurements are made with peak detectors). A sample calculation is included below.

$$FS = RA + AF + CF - AG$$

where FS = Field Strength in dB $\mu$ V/m

RA = Receiver Amplitude (including preamplifier) in dB $\mu$ V

CF = Cable Attenuation Factor in dB

AF = Antenna Factor in dB/m

AG = Amplifier Gain in dB

In the radiated emission table which follows, the reading shown on the data table may reflect the preamplifier gain. An example of the calculations, where the reading does not reflect the preamplifier gain, follows:

$$FS = RA + AF + CF - AG$$

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### 3.1 Field Strength Calculation (cont'd)

#### Example

Assume a receiver reading of 62.0dB $\mu$ V is obtained. The antenna factor of 7.4dB/m and cable factor of 1.6dB is added. The amplifier gain of 29dB is subtracted. The net field strength for comparison to the appropriate emission limit is 42dB $\mu$ V/m. This value in dB $\mu$ V/m was converted to its corresponding level in  $\mu$ V/m.

$$RA = 62.0\text{dB}\mu\text{V}$$

$$AF = 7.4\text{dB/m}$$

$$CF = 1.6\text{dB}$$

$$AG = 29.0\text{dB}$$

$$FS = 62 + 7.4 + 1.6 - 29 = 42\text{dB}\mu\text{V/m}$$

$$\text{Level in } \mu\text{V/m} = \text{Common Antilogarithm } [(42\text{dB}\mu\text{V/m})/20] = 125.9\mu\text{V/m}$$

## INTERTEK TESTING SERVICES

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### 3.2 Radiated Emission Configuration Photograph

Worst Case Radiated Emission  
At  
741.980MHz (HDMI In Mode)

For electronic filing, the worst case radiated emission configuration photograph is saved with filename: radiated photos.pdf.



## INTERTEK TESTING SERVICES

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### 3.3 Radiated Emission Data

The data on the following page lists the significant emission frequencies, the limit and the margin of compliance. Numbers with a minus sign are below the limit.

Judgement: Passed by 5.7dB margin (HDMI In Mode)

#### **TEST PERSONNEL:**

*Sign on file*

Jenner Liu Assistant Engineer

*Typed/Printed Name*

March 10, 2015

*Date*

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## INTERTEK TESTING SERVICES

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Company: Hisense Electric Co., Ltd.

Date of Test: March 10, 2015

Model: LTDN40D50US

Operating Mode: HDMI In

**Table 1**

**Radiated Emissions**

Polarization	Frequency (MHz)	Reading (dBμV)	Pre-Amp Gain (dB)	Antenna Factor (dB)	Net at 3m (dBμV/m)	Limit at 3m (dBμV/m)	Margin (dB)
Horizontal	148.340	45.1	20.0	10.6	35.7	43.5	-7.8
Horizontal	291.900	39.2	20.0	15.4	34.6	46.0	-11.4
Horizontal	741.980	32.7	20.0	25.0	37.7	46.0	-8.3
Horizontal	1483.000	27.6	20.0	25.7	33.3	54.0	-20.7
Horizontal	1594.000	28.1	20.0	25.9	34.0	54.0	-20.0
Horizontal	1632.000	27.9	20.0	26.6	34.5	54.0	-19.5
Vertical	51.360	44.4	20.0	7.9	32.3	40.0	-7.7
Vertical	90.625	44.1	20.0	9.3	33.4	43.5	-10.1
Vertical	741.980	35.3	20.0	25.0	40.3	46.0	-5.7
Vertical	1335.000	31.6	20.0	24.3	35.9	54.0	-18.1
Vertical	1780.000	26.0	20.0	27.5	33.5	54.0	-20.5
Vertical	1929.000	26.6	20.0	28.6	35.2	54.0	-18.8

**NOTES:**

1. Quasi-Peak detector is used for frequency up to 1GHz and Peak detector is used for frequency from 1-2GHz.
2. All measurements were made at 3 meters.
3. Negative value in the margin column shows emission below limit.
4. All emissions up to 1GHz are below the QP limit and all emissions between 1-2GHz are below the AV limit.

Test Engineer: Jenner Liu

## INTERTEK TESTING SERVICES

Company: Hisense Electric Co., Ltd.

Date of Test: March 10, 2015

Model: LTDN40D50US

Operating Mode: VGA

**Table 1**

### **Radiated Emissions**

Polarization	Frequency (MHz)	Reading (dBμV)	Pre-Amp Gain (dB)	Antenna Factor (dB)	Net at 3m (dBμV/m)	Limit at 3m (dBμV/m)	Margin (dB)
Horizontal	252.130	43.1	20.0	14.3	37.4	46.0	-8.6
Horizontal	267.165	42.6	20.0	14.6	37.2	46.0	-8.8
Horizontal	326.820	42.7	20.0	16.4	39.1	46.0	-6.9
Horizontal	1137.000	23.6	20.0	23.7	27.3	54.0	-26.7
Horizontal	1571.000	22.9	20.0	26.4	29.3	54.0	-24.7
Horizontal	1669.000	24.0	20.0	27.2	31.2	54.0	-22.8
Vertical	49.885	45.1	20.0	8.0	33.1	40.0	-6.9
Vertical	103.720	41.3	20.0	10.0	31.3	43.5	-12.2
Vertical	150.765	40.6	20.0	10.8	31.4	43.5	-12.1
Vertical	1178.000	26.0	20.0	23.4	29.4	54.0	-24.6
Vertical	1276.000	24.4	20.0	24.0	28.4	54.0	-25.6
Vertical	1858.000	21.9	20.0	28.1	30.0	54.0	-24.0

#### NOTES:

1. Quasi-Peak detector is used for frequency up to 1GHz and Peak detector is used for frequency from 1-2GHz.
2. All measurements were made at 3 meters.
3. Negative value in the margin column shows emission below limit.
4. All emissions up to 1GHz are below the QP limit and all emissions between 1-2GHz are below the AV limit.

Test Engineer: Jenner Liu

## **INTERTEK TESTING SERVICES**

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3.4 Conducted Emission at Mains Terminal

3.5 Conducted Emission Configuration Photograph

Worst Case Conducted Configuration  
at  
0.310 MHz(VGA Mode)

For electronic filing, the worst case conducted emission configuration photograph is saved with filename: conducted photos.pdf.

## INTERTEK TESTING SERVICES

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### 3.6 Conducted Emission Data

Judgement: Passed by 6.2 dB margin (VGA Mode)

#### **TEST PERSONNEL:**

*Sign on file*

Jenner Liu Assistant Engineer

*Typed/Printed Name*

March 10, 2015

*Date*

## INTERTEK TESTING SERVICES

Company: Hisense Electric Co., Ltd.

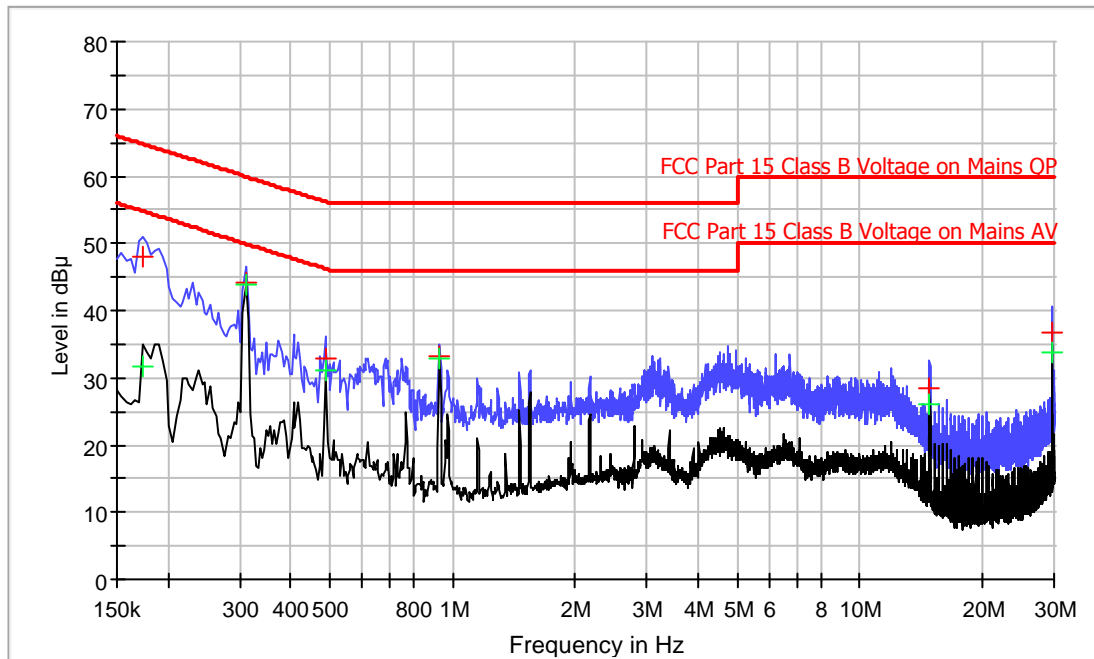
Date of Test: March 10, 2015

Model: LTDN40D50US

Operating Mode: VGA

Phase: Live

### Conducted Emission Test - FCC



### Result Table QP

Frequency (MHz)	QuasiPeak (dB μV)	Line	Corr. (dB)	Margin (dB)	Limit (dB μV)
0.174	47.9	L1	9.8	16.9	64.8
0.310	44.1	L1	9.8	15.9	60.0
0.486	32.9	L1	9.8	23.3	56.2
0.930	33.1	L1	9.9	22.9	56.0
14.850	28.5	L1	10.2	31.5	60.0
29.698	36.9	L1	10.6	23.1	60.0

### Result Table AV

Frequency (MHz)	Average (dB μV)	Line	Corr. (dB)	Margin (dB)	Limit (dB μV)
0.174	31.7	L1	9.8	23.1	54.8
0.310	43.8	L1	9.8	6.2	50.0
0.486	31.0	L1	9.8	15.2	46.2
0.930	32.9	L1	9.9	13.1	46.0
14.850	26.0	L1	10.2	24.0	50.0
29.698	33.9	L1	10.6	16.1	50.0

Test Engineer: Jenner Liu

TRF No.: FCC 15C\_PC\_b

FCC ID: W9HLCDD0044

## INTERTEK TESTING SERVICES

Company: Hisense Electric Co., Ltd.

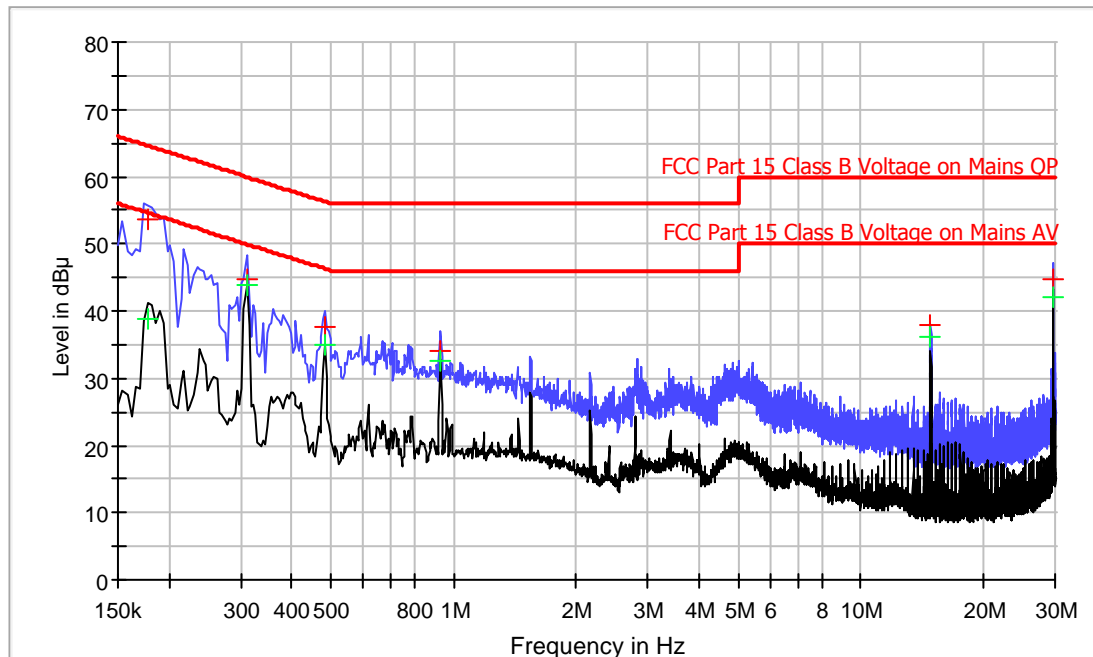
Date of Test: March 10, 2015

Model: LTDN40D50US

Operating Mode: VGA

Phase: Neutral

### Conducted Emission Test - FCC



### Result Table QP

Frequency (MHz)	QuasiPeak (dB $\mu$ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB $\mu$ V)
0.178	53.5	N	10.0	11.1	64.6
0.310	44.7	N	10.1	15.3	60.0
0.482	37.8	N	10.1	18.5	56.3
0.930	34.1	N	10.2	21.9	56.0
14.850	37.9	N	10.5	22.1	60.0
29.698	44.8	N	10.7	15.2	60.0

### Result Table AV

Frequency (MHz)	Average (dB $\mu$ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB $\mu$ V)
0.178	38.9	N	10.0	15.7	54.6
0.310	43.7	N	10.1	6.3	50.0
0.482	35.0	N	10.1	11.3	46.3
0.930	32.7	N	10.2	13.3	46.0
14.850	36.2	N	10.5	13.8	50.0
29.698	42.2	N	10.7	7.8	50.0

Test Engineer: Jenner Liu

TRF No.: FCC 15C\_PC\_b

FCC ID: W9HLCDD0044

## INTERTEK TESTING SERVICES

Company: Hisense Electric Co., Ltd.

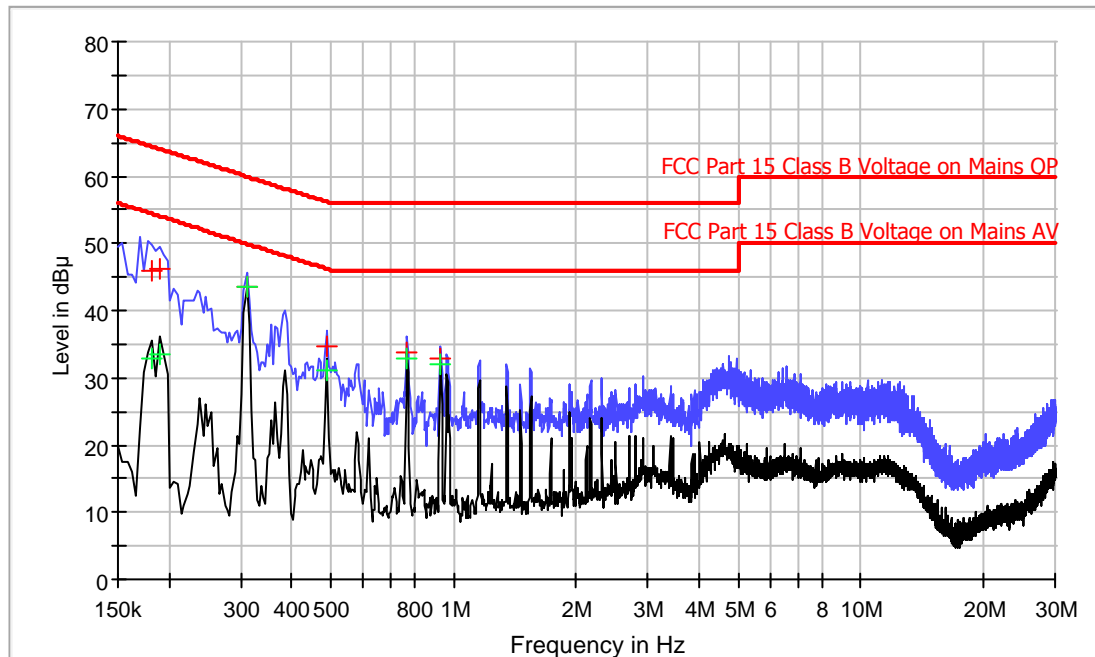
Date of Test: March 10, 2015

Model: LTDN40D50US

Operating Mode: HDMI In

Phase: Live

### Conducted Emission Test - FCC



### Result Table QP

Frequency (MHz)	QuasiPeak (dB $\mu$ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB $\mu$ V)
0.182	45.8	L1	9.8	18.6	64.4
0.190	46.1	L1	9.8	17.9	64.0
0.310	43.7	L1	9.8	16.3	60.0
0.486	34.8	L1	9.8	21.4	56.2
0.770	33.8	L1	10.0	22.2	56.0
0.930	32.9	L1	9.9	23.1	56.0

### Result Table AV

Frequency (MHz)	Average (dB $\mu$ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB $\mu$ V)
0.182	32.9	L1	9.8	21.5	54.4
0.190	33.5	L1	9.8	20.5	54.0
0.310	43.6	L1	9.8	6.4	50.0
0.486	31.2	L1	9.8	15.0	46.2
0.770	32.8	L1	10.0	13.2	46.0
0.930	32.1	L1	9.9	13.9	46.0

Test Engineer: Jenner Liu

TRF No.: FCC 15C\_PC\_b

FCC ID: W9HLCDD0044



## INTERTEK TESTING SERVICES

Company: Hisense Electric Co., Ltd.

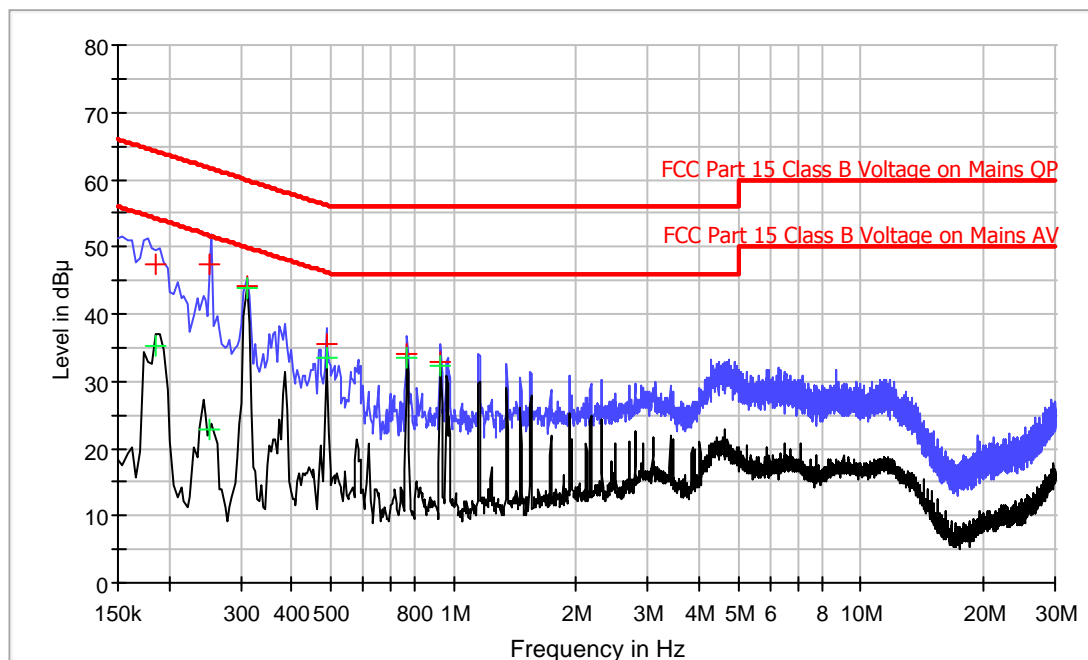
Date of Test: March 10, 2015

Model: LTDN40D50US

Operating Mode: HDMI In

Phase: Neutral

### Conducted Emission Test - FCC



### Result Table QP

Frequency (MHz)	QuasiPeak (dB $\mu$ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB $\mu$ V)
0.186	47.5	N	10.0	16.7	64.2
0.252	47.3	N	10.1	14.4	61.7
0.310	43.9	N	10.1	16.1	60.0
0.486	35.6	N	10.1	20.6	56.2
0.770	34.2	N	10.2	21.8	56.0
0.930	33.0	N	10.2	23.0	56.0

### Result Table AV

Frequency (MHz)	Average (dB $\mu$ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB $\mu$ V)
0.186	35.2	N	10.0	19.0	54.2
0.252	22.8	N	10.1	28.9	51.7
0.310	43.7	N	10.1	6.3	50.0
0.486	33.5	N	10.1	12.7	46.2
0.770	33.6	N	10.2	12.4	46.0
0.930	32.2	N	10.2	13.8	46.0

Test Engineer: Jenner Liu

TRF No.: FCC 15C\_PC\_b

FCC ID: W9HLCDD0044

## **INTERTEK TESTING SERVICES**

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### **EXHIBIT 4**

### **EQUIPMENT PHOTOGRAPHS**

## INTERTEK TESTING SERVICES

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### 4.0 **Equipment Photographs**

For electronic filing, photographs of the tested EUT are saved with filename: external photos.pdf and internal photos.pdf.

**EXHIBIT 5**  
**PRODUCT LABELLING**

## INTERTEK TESTING SERVICES

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### 5.0 **Product Labelling**

For electronics filing, the FCC ID label artwork and the label location are saved with filename: label.pdf.

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## **INTERTEK TESTING SERVICES**

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### **EXHIBIT 6**

### **TECHNICAL SPECIFICATIONS**

## INTERTEK TESTING SERVICES

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### 6.0 **Technical Specifications**

For electronic filing, the block diagram of the tested EUT is saved with filename: block.pdf.

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## **INTERTEK TESTING SERVICES**

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### **EXHIBIT 7**

### **INSTRUCTION MANUAL**



## INTERTEK TESTING SERVICES

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### 7.0 **Instruction Manual**

For electronic filing, a preliminary copy of the Instruction Manual is saved with filename: manual.pdf.

This manual will be provided to the end-user with each unit sold / leased in the United States.

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## **INTERTEK TESTING SERVICES**

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### **EXHIBIT 8**

### **MISCELLANEOUS INFORMATION**

## INTERTEK TESTING SERVICES

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### 8.0 **Miscellaneous Information**

This miscellaneous information includes emission measuring procedure.

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## INTERTEK TESTING SERVICES

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### 8.1 Emissions Test Procedures

The following is a description of the test procedure used by Intertek Testing Services in the measurements of computer peripheral operating under Part 15, Subpart B rules.

The test set-up and procedures described below are designed to meet the requirements of ANSI C63.4 – 2009.

The computer peripheral equipment under test (EUT) is placed on a wooden turntable which is four feet in diameter and approximately one meter in height above the ground plane. During the radiated emissions test, the turntable is rotated and any cables leaving the EUT are manipulated to find the configuration resulting in maximum emissions. The antenna height and polarization are varied during the testing to search for maximum signal levels. The height of the antenna is varied from one to four meters.

Detector function for radiated emissions are in QP mode from the frequency band 30MHz to 1GHz with RBW setting 120kHz and in PK & AV mode from frequency band 1GHz to 2GHz with RBW setting 1MHz. Detector function for conducted emissions are in QP & AV mode and IFBW setting is 9kHz from the frequency band 150kHz to 30MHz.

For radiated emission, the frequency range scanned is 30MHz to 2GHz. For line-conducted emissions, the range scanned is 150kHz to 30MHz.

## **INTERTEK TESTING SERVICES**

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### **8.1 Emissions Test Procedures (cont'd)**

The EUT is warmed up for 15 minutes prior to the test.

Conducted measurements are made as described in ANSI C63.4 – 2009.

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## **INTERTEK TESTING SERVICES**

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### **EXHIBIT 9**

### **TEST EQUIPMENT LIST**

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## INTERTEK TESTING SERVICES

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### 9.0 Test Equipment List

Equipment No.	Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Due Date
SZ061-03	Biconilog Antenna	ETS	3142C	00066460	28-Jun-2014	28-Jun-2015
SZ061-08	Horn Antenna	ETS	3115	00092346	19-Oct-2014	19-Oct-2015
EM031-03	EXA Spectrum Analyzer	R&S	FSV40	101506	09-Jun-2014	09-Jun-2015
SZ185-01	EMI Receiver	R & S	ESCI	100547	07-Feb-2015	07-Feb-2016
SZ188-01	Anechoic Chamber	ETS	RFD-F/A-100	4102	19-Apr-2014	19-Apr-2015
SZ062-04	RF Cable	RADIALL	RG 213U	--	04-Jan-2015	04-Jul-2015
SZ185-02	EMI Test Receiver	R&S	ESCI	100692	01-Nov-2014	01-Nov-2015
SZ187-01	Two-Line V-Network	R&S	ENV216	100072	01-Nov-2014	01-Nov-2015
SZ187-02	Two-Line V-Network	R&S	ENV216	100073	16-Jun-2014	16-Jun-2015
SZ188-03	Shielding Room	ETS	RFD-100	4100	23-Aug-2014	23-Aug-2015